TOSHIBA Field Effect Transistor Silicon N Channel MOS Type ($L^2-\pi^-MOSV$)

2SK2385

Chopper Regulator, DC-DC Converter and Motor Drive Applications

• 4 V gate drive

• Low drain-source ON resistance $: R_{DS}(ON) = 22 \text{ m}\Omega \text{ (typ.)}$

• High forward transfer admittance $|Y_{fs}| = 27 \text{ S (typ.)}$

• Low leakage current : $I_{DSS} = 100 \mu A \text{ (max) (V}_{DS} = 60 \text{ V)}$

• Enhancement-mode : $V_{th} = 0.8 \sim 2.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

Characteri	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	60	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	60	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	36	Α	
	Pulse (Note 1)	I_{DP}	144	Α	
Drain power dissipatio	n (Tc = 25°C)	P _D	40	W	
Single pulse avalanch	e energy (Note 2)	E _{AS}	365	mJ	
Avalanche current		I _{AR}	36	Α	
Repetitive avalanche energy (Note 3)		E _{AR}	4	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Weight: 1.9 g (typ.)

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	3.125	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	62.5	°C/W

Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2: V_{DD} = 25 V, T_{ch} = 25°C (initial), L = 383 μ H, R_G = 25 Ω , I_{AR} = 36 A

Note 3: Repetitive rating; Pulse width limited by maximum channel temperature.

This transistor is an electrostatic sensitive device.

Please handle with caution.



Electrical Characteristics (Ta = 25°C)

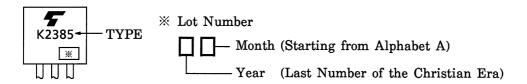
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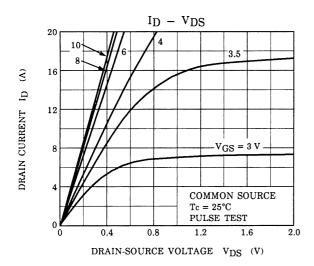
Charac	eteristics	Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V		_	±10	μΑ	
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 60 V, V _{GS} = 0 V		_	100	μΑ	
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	60	_	_	V	
Gate threshold v	/oltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	8.0	_	2.0	V	
Drain-source ON resistance		R _{DS (ON)}	V _{GS} = 4 V, I _D = 15 A	_	40	55	1	
			V _{GS} = 10 V, I _D = 18 A		22	30	mΩ	
Forward transfer	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 18 A		27	_	S	
Input capacitano	e	C _{iss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		1800	-	pF	
Reverse transfe	r capacitance	C _{rss}			350	_		
Output capacitance		C _{oss}			900	_		
Switching time	Rise time	t _r	$V_{GS} = 10V$ $V_{GS} = 10V$ $V_{OUT} = 18A$	_	20	_	- ns	
	Turn-on time	t _{on}		_	30	_		
	Fall time	t _f		_	40	_		
	Turn-off time	t _{off}	$V_{DD} = 30V$ Duty \le 1\%, t _w = 10\mu s	_	130	_		
Total gate charg plus gate-drain)		Qg			60	_		
Gate-source charge		Q _{gs}	$V_{DD} \approx 48 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 36 \text{ A}$		40	_	nC	
Gate-drain ("mil	ler") charge	Q _{gd}	Q _{gd}		20	_		

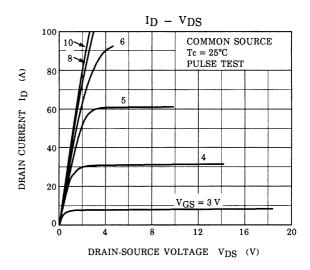
Source-Drain Ratings and Characteristics (Ta = 25°C)

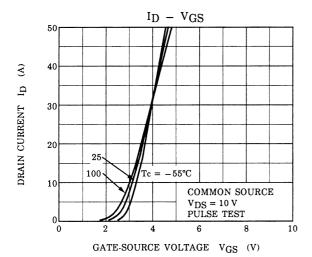
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	36	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	144	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = 36 A, V _{GS} = 0 V	_	_	-1.8	V
Reverse recovery time	t _{rr}	I _{DR} = 36 A, V _{GS} = 0 V	_	60	_	ns
Reverse recovered charge	Q _{rr}	dI _{DR} / dt = 50 Å / μs	_	51	_	μC

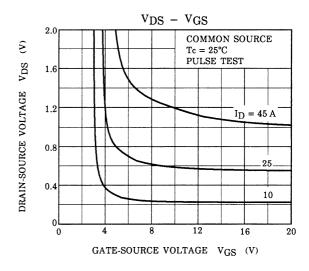
Marking

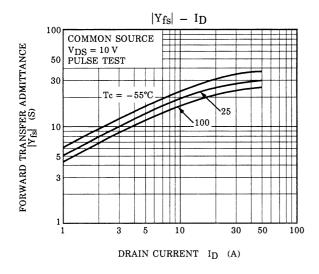


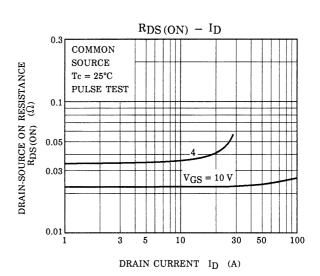


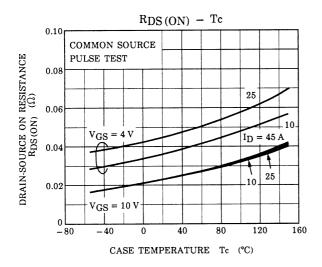


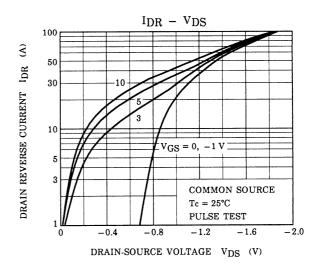


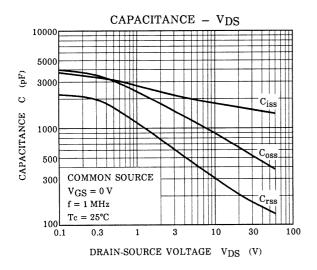


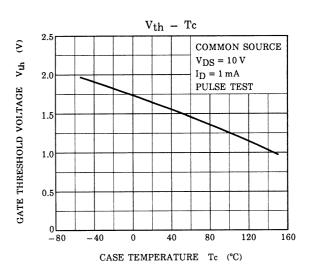


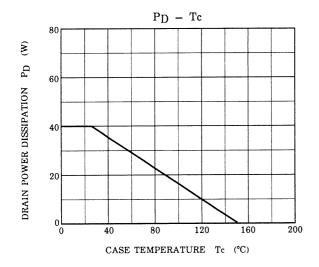


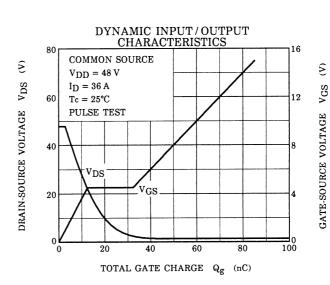


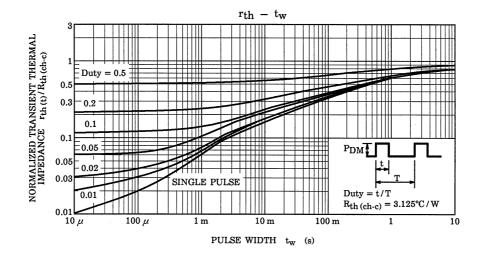


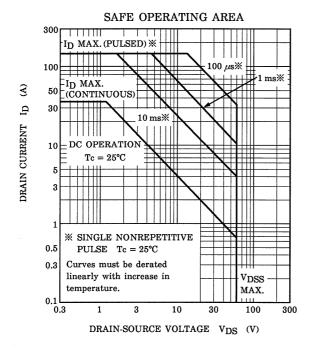


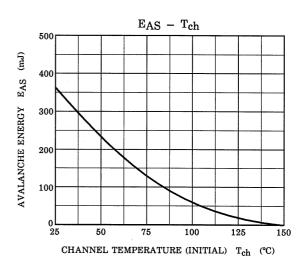


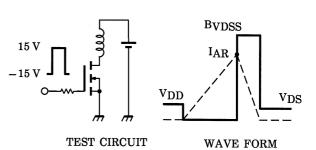












$$\begin{aligned} &R_G = 25~\Omega \\ &V_{DD} = 25~V,~L = 383~\mu H \end{aligned} \qquad EAS = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{BVDSS}{BVDSS - VDD} \right) \end{aligned}$$

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